

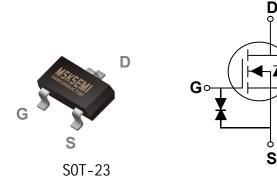


# Product data sheet

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BVDSS	RDSON	ID
55V	1.2R	0.3A

#### Features

- 55V,0.3A, RDS(ON) =1.2Ω@VGS=10V
- Improved dv/dt capability
- Fast switching
- Green Device Available
- G-S ESD Protection Diode Embedded
- ESD protected up to 2KV

#### Applications

- Motor Drive
- Power Tools
- LED Lighting

## Absolute Maximum Ratings T Tc=25°C unless otherwise noted

Symbol	Parameter	Rating	Units
Vds	Drain-Source Voltage	55	V
Vgs	Gate-Source Voltage	±20	V
L-	Drain Current – Continuous (T₄=25℃)	0.3	А
D	Drain Current – Continuous (T <sub>A</sub> =70°C)	0.16	А
Ідм	Drain Current – Pulsed <sup>1</sup>	0.8	Α
<b>D</b> -	Power Dissipation (T <sub>A</sub> =25°C)	0.35	W
Po	Power Dissipation – Derate above 25°C	0.003	W/°C
Тѕтс	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C

#### **Thermal Characteristics**

Symbol	Parameter	Тур.	Max.	Unit
Reja	Thermal Resistance Junction to ambient		357	°C/W



#### , unless otherwise noted) Electrical Characteristics (T<sub>J</sub>=25

#### **Off Characteristics**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BVDSS	Drain-Source Breakdown Voltage	Vgs=0V , Ib=250uA	55			V
	Drain Source Leekene Current	Vɒs=55V , Vσs=0V , Tյ=25℃			1	uA
IDSS Drain-Source Leakage Current		V⊳s=40V , V₀s=0V , T」=125℃			100	uA
lgss	Gate-Source Leakage Current	Vgs= ±20V , Vds=0V			±10	uA

#### **On Characteristics**

Bactory	Static Drain-Source On-Resistance	Vgs=10V , Id=0.2A		1.2	1.5	Ω
RDS(ON)		Vgs=4.5V , Id=0.1A		1.5	2.5	Ω
VGS(th)	Gate Threshold Voltage	Vgs=Vds , Id =250uA	0.8	1.1	1.5	V
gfs	Forward Transconductance	Vds=10V , Id=0.2A		0.5		S

### Dynamic and switching Characteristics

Qg	Total Gate Charge <sup>2,3</sup>		 3.7	
Qgs	Gate-Source Charge <sup>2,3</sup>	Vds=30V , Vgs=10V , Id=0.2A	 0.9	 nC
Qgd	Gate-Drain Charge <sup>2,3</sup>		 0.4	
Td(on)	Turn-On Delay Time <sup>2,3</sup>		 3	
Tr	Rise Time <sup>2,3</sup>	VDD=30V , VGS=10V , RG=6 $\Omega$	 5	
Td(off)	Turn-Off Delay Time <sup>2 , 3</sup>	ID=0.2A	 14	 ns
Tf	Fall Time <sup>2 , 3</sup>		 9	
Ciss	Input Capacitance		 25.5	
Coss	Output Capacitance	Vbs=30V , Vgs=0V , F=1MHz	 17	 pF
Crss	Reverse Transfer Capacitance		 7.8	

## Drain-Source Diode Characteristics and Maximum Ratings

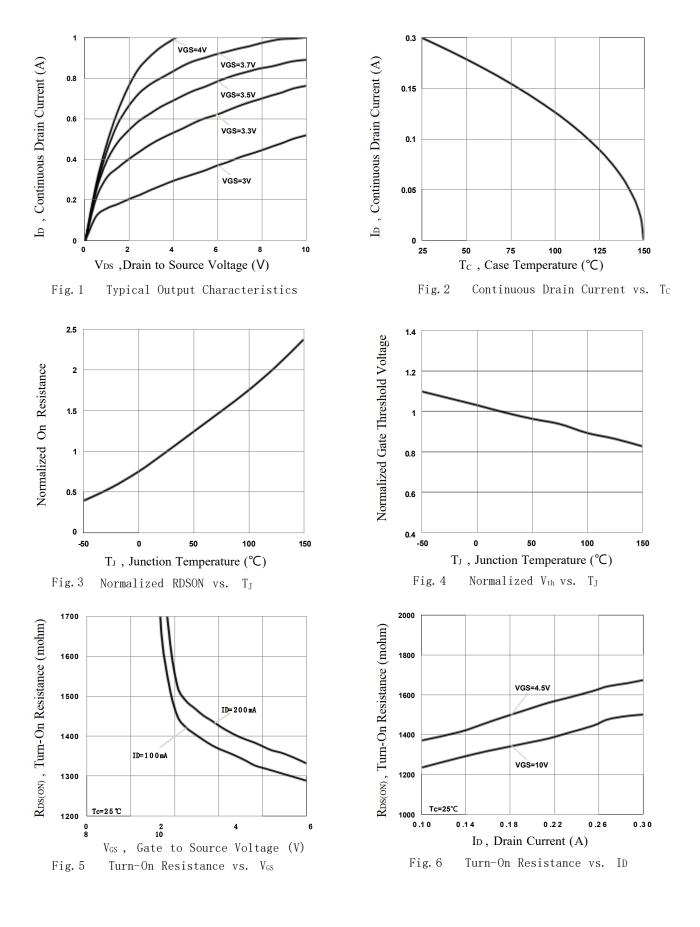
Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
ls	Continuous Source Current	$\lambda(z=\lambda(z=0))$			0.3	А
Іѕм	Pulsed Source Current	V <sub>G</sub> =V <sub>D</sub> =0V , Force Current			0.6	А
Vsd	Diode Forward Voltage	Vgs=0V , Is=0.2A , Tյ=25℃			1.4	V
trr	Reverse Recovery Time V <sub>R</sub> =50V, Is=0.2A			3.4		ns
Qrr	Reverse Recovery Charge	dl/dt=100A/µs, Tյ=25℃		0.7		nC

Note :

 Repetitive Rating : Pulsed width limited by maximum junction temperature.
 The data tested by pulsed , pulse width ≤ 300us , duty cycle ≤ 2%.
 Essentially independent of operating temperature.



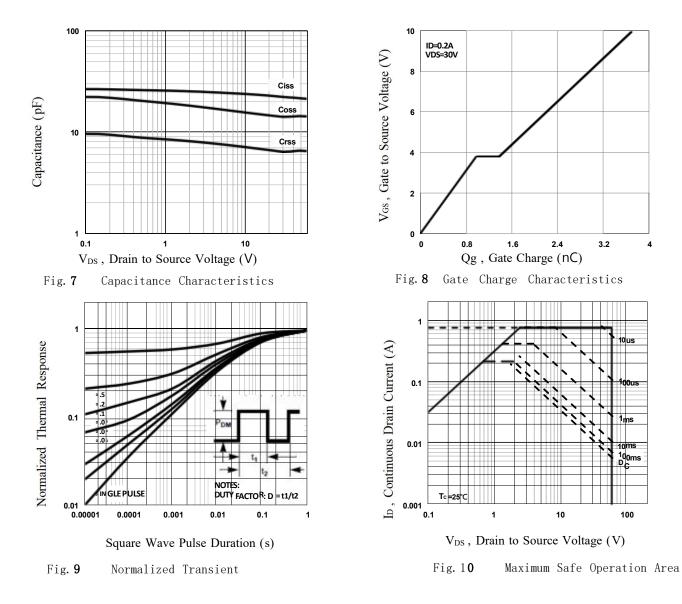
BVSS138LT1G Semiconductor







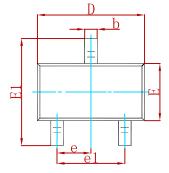
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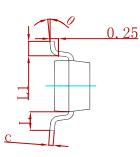


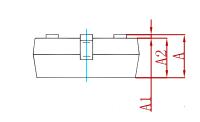




## PACKAGE MECHANICAL DATA

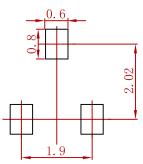






Symbol	Dimensions	Dimensions In Millimeters		s in inches
Symbol	Min	Max	Min	Max
Α	0.900	1.150	0.035	0.045
A1	0.000	0.100	0.000	0.004
A2	0.900	1.050	0.035	0.041
b	0.300	0.500	0.012	0.020
С	0.080	0.150	0.003	0.006
D	2.800	3.000	0.110	0.118
E	1.200	1.400	0.047	0.055
E1	2.250	2.550	0.089	0.100
е	0.950	)TYP	0.037	'TYP
e1	1.800	2.000	0.071	0.079
L	0.550 REF		0.022	REF
L1	0.300	0.500	0.012	0.020
θ	0°	8°	0°	8°

## Suggested Pad Layout



Note:

Controlling dimension:in millimeters.
 General tolerance:± 0.05mm.
 The pad layout is for reference purposes only.

#### **REEL SPECIFICATION**

P/N	PKG	QTY
BVSS138LT1G	SOT-23	3000



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